### 3.0 V OPERATION SILICON RF POWER LD-MOS FET FOR 460 MHz 0.6 W TRANSMISSION AMPLIFIERS

## DESCRIPTION

The NE552R679A is an N-channel silicon power laterally diffused MOS FET specially designed as the transmission power amplifier for 3.0 V FRS (Family Radio Service). Dies are manufactured using our NEWMOS2 technology (our WSi gate lateral-diffusion MOS FET) and housed in a surface mount package. This device can deliver 28.0 dBm output power with $60 \%$ power added efficiency at 460 MHz under the 3.0 V supply voltage.

## FEATURES

- High output power : Pout $=28.0 \mathrm{dBm}$ TYP. (Vos $=3.0 \mathrm{~V}$, IDset $=300 \mathrm{~mA}, f=460 \mathrm{MHz}, \mathrm{Pin}=15 \mathrm{dBm})$
- High power added efficiency : $\eta_{\text {add }}=60 \%$ TYP. (Vos $=3.0 \mathrm{~V}$, IDset $\left.=300 \mathrm{~mA}, f=460 \mathrm{MHz}, \operatorname{Pin}=15 \mathrm{dBm}\right)$
- High linear gain : GL=20 dB TYP. (VDs $=3.0 \mathrm{~V}$, IDset $=300 \mathrm{~mA}, \mathrm{f}=460 \mathrm{MHz}, \mathrm{Pin}=5 \mathrm{dBm})$
- Surface mount package $: 5.7 \times 5.7 \times 1.1 \mathrm{~mm}$ MAX.
- Single supply : VDs $=2.8$ to 6.0 V


## APPLICATIONS

- Family Radio Service : 3.0 V Handsets


## ORDERING INFORMATION

| Part Number | Package | Marking | Supplying Form |
| :---: | :---: | :---: | :---: |
| NE552R679A-T1 | 79A | AU | - 12 mm wide embossed taping <br> - Gate pin face the perforation side of the tape <br> - Qty $1 \mathrm{kpcs} / \mathrm{ree}$ |
| NE552R679A-T1A |  |  | - 12 mm wide embossed taping <br> - Gate pin face the perforation side of the tape <br> - Qty 5 kpcs/reel |

Remark To order evaluation samples, contact your nearby sales office.
Part number for sample order: NE552R679A

Caution Observe precautions when handling because these devices are sensitive to electrostatic discharge.

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## ABSOLUTE MAXIMUM RATINGS ( $\mathrm{T}_{\mathrm{A}}=\boldsymbol{+ 2 5 ^ { \circ }} \mathbf{C}$ )

| Parameter | Symbol | Ratings | Unit |
| :---: | :---: | :---: | :---: |
| Drain to Source Voltage | V ${ }_{\text {ds }}$ | 15.0 | V |
| Gate to Source Voltage | VGS | 5.0 | V |
| Drain Current | Ids | 350 | mA |
| Drain Current (Pulse Test) | Ids ${ }^{\text {Note }}$ | 600 | mA |
| Total Power Dissipation | $\mathrm{P}_{\text {tot }}$ | 10 | W |
| Channel Temperature | Tch | 125 | ${ }^{\circ} \mathrm{C}$ |
| Storage Temperature | $\mathrm{T}_{\text {stg }}$ | -55 to +125 | ${ }^{\circ} \mathrm{C}$ |

Note Duty Cycle $50 \%$, Ton $\leq 1 \mathrm{~s}$

## RECOMMENDED OPERATING CONDITIONS

| Parameter | Symbol | Test Conditions | MIN. | TYP. | MAX. | Unit |
| :--- | :---: | :---: | :---: | :---: | :---: | :---: |
| Drain to Source Voltage | Vos |  | 2.8 | 3.0 | 6.0 | V |
| Gate to Source Voltage | VGs |  | 0 | 2.0 | 3.0 | V |
| Drain Current | IDS |  | - | 300 | 500 | mA |
| Input Power | Pin | $\mathrm{f}=460 \mathrm{MHz}, \mathrm{VDS}=3.0 \mathrm{~V}$ | 14 | 15 | 20 | dBm |

## ELECTRICAL CHARACTERISTICS

( $\mathrm{T}_{\mathrm{A}}=+\mathbf{2 5 ^ { \circ }} \mathrm{C}$, Unless otherwise specified, using NEC standard test fixture)

| Parameter | Symbol | Test Conditions | MIN. | TYP. | MAX. | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Gate to Source Leak Current | Igss | $\mathrm{V}_{\mathrm{gs}}=5.0 \mathrm{~V}$ | - | - | 100 | nA |
| Saturated Drain Current <br> (Zero Gate Voltage Drain Current) | loss | $\mathrm{VDS}=8.0 \mathrm{~V}$ | - | - | 100 | nA |
| Gate Threshold Voltage | $\mathrm{V}_{\text {th }}$ | V DS $=3.5 \mathrm{~V}$, $\mathrm{los}=1 \mathrm{~mA}$ | 1.0 | 1.4 | 1.9 | V |
| Thermal Resistance | Rth | Channel to Case | - | - | 10 | ${ }^{\circ} \mathrm{C} / \mathrm{W}$ |
| Transconductance | gm | V ds $=3.0 \mathrm{~V}$, los $=300 \mathrm{~mA}$ | - | 0.6 | - | S |
| Drain to Source Breakdown Voltage | BVoss | loss $=10 \mu \mathrm{~A}$ | 15 | 18 | - | V |
| Output Power | Pout | $\begin{aligned} & f=460 \mathrm{MHz}, \mathrm{Vds}=3.0 \mathrm{~V}, \\ & \mathrm{P}_{\text {in }}=15 \mathrm{dBm}, \\ & \text { loset }=300 \mathrm{~mA}(\text { RF OFF }), \text { Note1 } \end{aligned}$ | 26.0 | 28.0 | - | dBm |
| Drain Current | los |  | - | 320 | - | mA |
| Power Added Efficiency | $\eta_{\text {add }}$ |  | 55 | 60 | - | \% |
| Linear Gain ${ }^{\text {Note2 }}$ | G |  | - | 20 | - | dB |

Note 1. DC performance is $100 \%$ testing. RF performance is testing several samples per wafer. Wafer rejection criteria for standard devices is 1 reject for several samples.
2. $\mathrm{Pin}_{\mathrm{in}}=5 \mathrm{dBm}$

## TYPICAL CHARACTERISTICS (TA $=+\mathbf{2 5}{ }^{\circ} \mathrm{C}$ )



Remark The graphs indicate nominal characteristics.

## S-PARAMETERS

Test Conditions: $\mathrm{V}_{\mathrm{DS}}=3.0 \mathrm{~V}$, IDset $=300 \mathrm{~mA}, \mathrm{~T}_{\mathrm{A}}=+25^{\circ} \mathrm{C}$ )

| Frequency | S11 |  | S21 |  |  | S12 |  |  | S22 |  | MAG ${ }^{\text {Note }}$ | MSG ${ }^{\text {Note }}$ | K |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| GHz | Mag. | Ang. | dB | Mag. | Ang. | dB | Mag. | Ang. | Mag. | Ang. | dB | dB | - |
| 0.1 | 0.655 | -120.2 | 21.2 | 11.42 | 115.3 | -31.6 | 0.026 | 28.7 | 0.633 | -167.5 |  | 26.4 | 0.59 |
| 0.2 | 0.651 | -142.0 | 17.2 | 7.25 | 99.3 | -29.0 | 0.035 | 10.3 | 0.757 | -167.9 |  | 23.1 | 0.36 |
| 0.3 | 0.666 | -156.1 | 13.8 | 4.89 | 88.2 | -29.3 | 0.034 | -0.1 | 0.796 | -173.0 |  | 21.5 | 0.40 |
| 0.4 | 0.660 | -161.4 | 11.5 | 3.74 | 81.6 | -29.2 | 0.034 | -5.6 | 0.808 | -175.0 |  | 20.4 | 0.50 |
| 0.5 | 0.656 | -165.8 | 9.4 | 2.96 | 77.2 | -29.2 | 0.035 | -11.8 | 0.815 | -175.9 |  | 19.3 | 0.62 |
| 0.6 | 0.655 | -168.4 | 7.8 | 2.46 | 72.6 | -29.3 | 0.034 | -15.9 | 0.819 | -176.8 |  | 18.6 | 0.76 |
| 0.7 | 0.654 | -170.2 | 6.5 | 2.10 | 68.4 | -29.5 | 0.033 | -20.1 | 0.823 | -177.4 |  | 18.0 | 0.91 |
| 0.8 | 0.658 | -171.8 | 5.2 | 1.81 | 64.4 | -29.6 | 0.033 | -24.2 | 0.828 | -178.0 | 16.2 |  | 1.04 |
| 0.9 | 0.656 | -172.8 | 4.1 | 1.61 | 60.6 | -29.7 | 0.033 | -27.6 | 0.831 | -179.4 | 14.2 |  | 1.20 |
| 1.0 | 0.658 | -173.8 | 3.1 | 1.43 | 56.6 | -29.8 | 0.032 | -31.5 | 0.835 | -179.9 | 12.8 |  | 1.37 |
| 1.1 | 0.663 | -175.0 | 2.1 | 1.27 | 53.3 | -30.0 | 0.031 | -35.3 | 0.840 | 179.6 | 11.7 |  | 1.54 |
| 1.2 | 0.668 | -175.8 | 1.1 | 1.14 | 49.9 | -30.2 | 0.031 | -39.1 | 0.843 | 179.2 | 10.7 |  | 1.75 |
| 1.3 | 0.668 | -176.8 | 0.4 | 1.04 | 46.6 | -30.3 | 0.030 | -42.1 | 0.846 | 178.7 | 9.8 |  | 1.93 |
| 1.4 | 0.668 | -177.6 | -0.4 | 0.96 | 43.7 | -30.6 | 0.030 | -45.4 | 0.851 | 178.2 | 9.1 |  | 2.14 |
| 1.5 | 0.672 | -178.5 | -1.1 | 0.88 | 40.6 | -30.7 | 0.029 | -49.0 | 0.853 | 177.7 | 8.2 |  | 2.38 |
| 1.6 | 0.674 | -179.2 | -1.8 | 0.81 | 37.5 | -31.0 | 0.028 | -51.8 | 0.857 | 177.4 | 7.6 |  | 2.61 |
| 1.7 | 0.673 | -180.0 | -2.5 | 0.75 | 34.6 | -31.1 | 0.028 | -55.3 | 0.859 | 176.6 | 6.8 |  | 2.87 |
| 1.8 | 0.675 | 179.2 | -3.2 | 0.69 | 31.7 | -31.3 | 0.027 | -58.6 | 0.862 | 176.1 | 6.1 |  | 3.20 |
| 1.9 | 0.677 | 178.5 | -3.8 | 0.65 | 28.9 | -31.6 | 0.026 | -61.5 | 0.864 | 175.5 | 5.5 |  | 3.51 |
| 2.0 | 0.677 | 177.8 | -4.4 | 0.61 | 26.4 | -31.7 | 0.026 | -64.6 | 0.867 | 174.9 | 5.0 |  | 3.76 |
| 2.1 | 0.677 | 177.0 | -4.9 | 0.57 | 24.0 | -31.9 | 0.025 | -68.3 | 0.869 | 174.2 | 4.4 |  | 4.12 |
| 2.2 | 0.677 | 176.2 | -5.4 | 0.54 | 21.2 | -32.2 | 0.025 | -71.4 | 0.869 | 173.6 | 3.8 |  | 4.57 |
| 2.3 | 0.681 | 175.4 | -6.0 | 0.50 | 19.2 | -32.2 | 0.025 | -75.1 | 0.863 | 172.6 | 3.0 |  | 5.14 |
| 2.4 | 0.677 | 174.7 | -6.5 | 0.48 | 16.6 | -32.5 | 0.024 | -78.2 | 0.873 | 172.4 | 2.8 |  | 5.35 |
| 2.5 | 0.675 | 174.6 | -6.9 | 0.45 | 13.9 | -32.7 | 0.023 | -82.0 | 0.874 | 171.7 | 2.2 |  | 5.82 |
| 2.6 | 0.674 | 173.8 | -7.4 | 0.43 | 11.7 | -32.8 | 0.023 | -85.1 | 0.874 | 170.9 | 1.7 |  | 6.29 |
| 2.7 | 0.673 | 173.2 | -7.9 | 0.40 | 9.5 | -33.0 | 0.022 | -89.7 | 0.873 | 170.1 | 1.2 |  | 6.90 |
| 2.8 | 0.670 | 172.3 | -8.3 | 0.39 | 7.8 | -33.2 | 0.022 | -92.3 | 0.875 | 169.4 | 0.8 |  | 7.45 |
| 2.9 | 0.667 | 171.4 | -8.7 | 0.37 | 5.7 | -33.4 | 0.021 | -96.7 | 0.874 | 168.7 | 0.3 |  | 8.10 |
| 3.0 | 0.665 | 170.7 | -9.1 | 0.35 | 3.5 | -33.4 | 0.021 | -101.5 | 0.873 | 167.9 | -0.2 |  | 8.64 |
| 3.1 | 0.662 | 169.9 | -9.5 | 0.33 | 1.4 | -33.7 | 0.021 | -106.4 | 0.873 | 167.2 | -0.8 |  | 9.63 |
| 3.2 | 0.648 | 168.9 | -9.8 | 0.32 | -0.1 | -34.1 | 0.020 | -111.8 | 0.879 | 166.8 | -1.0 |  | 10.28 |
| 3.3 | 0.656 | 168.6 | -10.4 | 0.30 | -1.4 | -34.6 | 0.019 | -117.6 | 0.872 | 165.7 | -1.7 |  | 12.13 |
| 3.4 | 0.652 | 167.6 | -10.6 | 0.29 | -2.8 | -35.3 | 0.017 | -122.0 | 0.871 | 164.9 | -2.1 |  | 13.80 |
| 3.5 | 0.651 | 167.1 | -11.0 | 0.28 | -4.5 | -35.6 | 0.017 | -123.8 | 0.871 | 164.1 | -2.4 |  | 14.87 |
| 3.6 | 0.648 | 166.2 | -11.3 | 0.27 | -6.6 | -35.6 | 0.017 | -126.7 | 0.870 | 163.1 | -2.8 |  | 15.51 |
| 3.7 | 0.644 | 165.4 | -11.6 | 0.26 | -7.9 | -35.7 | 0.016 | -130.5 | 0.869 | 162.3 | -3.2 |  | 16.66 |
| 3.8 | 0.641 | 164.7 | -12.0 | 0.25 | -10.1 | -36.0 | 0.016 | -135.9 | 0.868 | 161.4 | -3.7 |  | 18.41 |
| 3.9 | 0.636 | 163.8 | -12.3 | 0.24 | -11.5 | -36.1 | 0.016 | -140.3 | 0.867 | 160.4 | -4.0 |  | 19.61 |
| 4.0 | 0.633 | 163.0 | -12.6 | 0.23 | -12.5 | -36.2 | 0.015 | -144.7 | 0.865 | 159.4 | -4.4 |  | 21.02 |

Note When $K \geq 1$, the MAG (Maximum Available Gain) is used. $\quad$ MAG $=\left|\frac{S_{21}}{S_{12}}\right|\left(K-\sqrt{\left(K^{2}-1\right)}\right)$

When $\mathrm{K}<1$, the MSG (Maximum Stable Gain) is used.

$\Delta=\mathrm{S}_{11} \cdot \mathrm{~S}_{22}-\mathrm{S}_{21} \cdot \mathrm{~S}_{12}$


| $f(\mathrm{MHz})$ | $Z_{\text {in }}(\Omega)$ | Zol $(\Omega)^{\text {Note }}$ |
| :---: | :---: | :---: |
| 460 | $7.47+\mathrm{j} 18.24$ | $4.82+\mathrm{j} 5.04$ |

Note Zol is the conjugate of optimum load impedance at given voltage, idling current, input power and frequency.

EVALUATION BOARD for 460 MHz


## PACKAGE DIMENSIONS

79A (UNIT: mm)


79A PACKAGE RECOMMENDED P.C.B. LAYOUT (UNIT: mm)


## RECOMMENDED SOLDERING CONDITIONS

This product should be soldered and mounted under the following recommended conditions. For soldering methods and conditions other than those recommended below, contact your nearby sales office.


Caution Do not use different soldering methods together (except for partial heating).

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